

PERRY JOHNSON LABORATORY ACCREDITATION, INC. *Certificate of Accreditation*

Perry Johnson Laboratory Accreditation, Inc. has assessed the Laboratory of:

TOTAL Calibration Solutions, Inc. 7722 Metric Drive, Mentor, OH 44060

(Hereinafter called the Organization) and hereby declares that Organization is accredited in accordance with the recognized International Standard:

ISO/IEC 17025:2005 ANSI/NCSL Z540-1-1994

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (as outlined by the joint ISO-ILAC-IAF Communiqué dated January 2009):

Dimensional, Electrical, Mechanical, Thermodynamic, Time and Frequency, and Mass, Force and Weighing Device Calibration (As detailed in the supplement)

Accreditation claims for such testing and/or calibration services shall only be made from addresses referenced within this certificate. This Accreditation is granted subject to the system rules governing the Accreditation referred to above, and the Organization hereby covenants with the Accreditation body's duty to observe and comply with the said rules.

For PJLA:

Liacy Seusy

Tracy Szerszen President/Operations Manager

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Perry Johnson Laboratory Accreditation, Inc. (PJLA) 755 W. Big Beaver, Suite 1325 Troy, Michigan 48084

nitial Accreditation Date:	Issue Date:	Expiration Date:
September 4, 2017	January 1, 2018	March 31, 2020
Accreditatio	n No.: Certi	ficate No.:
97175	L	18-7

The validity of this certificate is maintained through ongoing assessments based on a continuous accreditation cycle. The validity of this certificate should be confirmed through the PJLA website: <u>www.pjlabs.com</u>



Total Calibration Solutions, Inc.

7722 Metric Drive, Mentor, OH, 44060 Contact Name: Mark Hanson Phone: 440-229-4811

Accreditation is granted to the facility to perform the following calibrations:

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Calipers ^{FO}	Up to 40 in	(12L + 150) µin	Gage Blocks /
Micrometers FO	Up to 6 in	(9.2L + 21) µin	Surface Plate
	6 in to 20 in	(16L + 177) µin	
Indicators, Dial, Test FO	Up to 4 in	(30L - 5.5) µin	-
Height Gages FO	Up to 48 in	(10L + 205) µin	
Optical Comparators X and Y Axis Linearity ^{FO}	Up to 12 in	200 µin	Gage Line Glass Standard
Optical Comparators Magnification ^{FO}	10 x , 20 x, 31.25 x, 50 x, 62.5 x, 100 x	200 µin	
Optical Comparators Angle ^{FO}	0°, 5°, 10°, 15°, 20°, 25°, 30°, 45°, 90°	0.10°	Gage Line Glass Standard and Angle Blocks

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MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Equipment to Measure DC	Up to 100 mV	1.8 μV	HP 3458A Opt 002
Voltage ^{FO}	100 mV to 1 V	7μV	
	1 V to 10 V	72 μV	
	10 V to 100 V	1.2 mV	
	100 V to 1 kV	30 mV	
	1 kV to 4 kV	2.2 V	Vitrek 4700
	4 kV to 10 kV	3.9 V	
	10 kV to 30 kV	0.027 kV	Vitrek 4700,
	30 kV to 50 kV	0.045 kV	Vitrek HVL-100
	50 kV to 100 kV	0.15 kV	
Equipment to Output DC	Up to 330 mV	8.2 μV	Fluke 5522A
Voltage ^{FO}	330 mV to 3.3 V	41 µV	
	3.3 V to 33 V	0.45 mV	
	33 V to 330 V	6.5 mV	
	330 V to 1 kV	23 mV	
Equipment to Measure DC	Up to 100 µA	7.4 nA	HP 3458A Opt 002
Current ^{FO}	100 µA to 1 mA	84 nA	
	1 mA to 10 mA	0.71 μΑ	
	10 mA to 100 mA	10 µA	
	100 mA to 1 A	0.16 mA	1



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Equipment to Measure DC	1 A to 3 A	11 mA	HP 3458A Opt 002,
Current ^{FO}	3 A to 11 A	40 mA	HP 34330A Shunt
	11 A to 20.5 A	73 mA	
Equipment to Source DC Current ^{FO}	Up to 330 µA	0.11 μΑ	Fluke 5522A
Current	330 µA to 3.3 mA	0.56 μΑ	
	3.3 mA to 33 mA	9.1 μΑ	
	33 mA to 330 mA	87 μΑ	
	330 mA to 1.1 A	0.29 mA	
	1.1 A to 3 A	1.3 mA	
	3 A to 11 A	7.1 mA	
	11 A to 20.5 A	25 mA	1
Equipment to Measure AC Vol At the listed frequencies ^{FO}	tage		HP 3458A Opt 002
Up to 1 kHz	Up to 10 mV	4.7 μV	
1 kHz to 20 kHz	Up to 10 mV	9.0 μV	
20 kHz to 100 kHz	Up to 10 mV	90 μV	
100 kHz to 300 kHz	Up to 10 mV	0.72 mV	
Equipment to Measure AC Vol At the listed frequencies ^{FO}	tage		
Up to 1 kHz	10 mV to 100 mV	12 µV	
1 kHz to 20 kHz	10 mV to 100 mV	20 μV	
20 kHz to 100 kHz	10 mV to 100 mV	0.10 mV	
100 kHz to 300 kHz	10 mV to 100 mV	0.39 mV	
Equipment to Measure AC Vol At the listed frequencies FO	tage		
Up to 1 kHz	100 mV to 1 V	0.12 mV]
1 kHz to 20 kHz	100 mV to 1 V	0.20 mV	
20 kHz to 50 kHz	100 mV to 1 V	0.39 mV	1
50 kHz to 100 kHz	100 mV to 1 V	0.97 mV	1
100 kHz to 300 kHz	100 mV to 1 V	3.60 mV	1
300 kHz to 500 kHz	100 mV to 1 V	12 mV	1
Equipment to Measure AC Vol At the listed frequencies ^{FO}	tage		1
Up to 10 Hz	1 V to 10 V	3.8 mV]
10 Hz to 20 Hz	1 V to 10 V	1.4 mV	1



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Equipment to Measure AC Voltage At the listed frequencies ^{FO}			HP 3458A Opt 002
20 Hz to 40 Hz	1 V to 10 V	1.2 mV	-
40 Hz to 1 kHz	1 V to 10 V	1.2 mV	-
1 kHz to 10 kHz	1 V to 10 V	2 mV	-
Equipment to Measure AC Vo At the listed frequencies ^{FO}	ltage		
10 kHz to 20 kHz	1 V to 10 V	2 mV	
20 kHz to 50 kHz	1 V to 10 V	3.9 mV	-
50 kHz to 100 kHz	1 V to 10 V	9.6 mV	-
Equipment to Measure AC Vo At the listed frequencies ^{FO}	ltage		
Up to 1 kHz	10 V to 100 V	27 mV	
1 kHz to 20 kHz	10 V to 100 V	28 mV	
20 kHz to 50 kHz	10 V to 100 V	45 mV	
50 kHz to 100 kHz	10 V to 100 V	0.15 V	
Equipment to Measure AC Vo At the listed frequencies ^{FO}	ltage		\geq
Up to 20 kHz	100 V to 1 kV	0.36 V	
Equipment to Measure AC Vo At the listed frequencies ^{FO}	ltage		Vitrek 4700
60 Hz	1 kV to 10 kV	0.021 kV	
60 Hz	10 kV to 75 kV	0.18 kV	Vitrek 4700, Vitrek HVL-100
Equipment to Source AC Volta At the listed frequencies ^{FO}	2		Fluke 5522A
10 Hz to 45 Hz	Up to 33 mV	35 μV	
45 Hz to 10 kHz	Up to 33 mV	12 µV	
10 kHz to 20 kHz	Up to 33 mV	14 µV]
20 kHz to 50 kHz	Up to 33 mV	42 μV]
50 kHz to 100 kHz	Up to 33 mV	0.14 mV]
100 kHz to 500 kHz	Up to 33 mV	0.34 mV	
Equipment to Source AC Volta At the listed frequencies ^{FO}	0		
10 Hz to 45 Hz	33 mV to 330 mV	0.12 mV	
45 Hz to 10 kHz	33 mV to 330 mV	60 µV	
10 kHz to 20 kHz	33 mV to 330 mV	65 μV	



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Equipment to Source AC Volta At the listed frequencies ^{FO}	age		Fluke 5522A
20 kHz to 50 kHz	33 mV to 330 mV	0.13 mV	
50 kHz to 100 kHz	33 mV to 330 mV	0.32 mV	
Equipment to Source AC Volta At the listed frequencies ^{FO}	age	1	-
10 Hz to 45 Hz	330 mV to 3.3 V	11 mV	-
45 Hz to 10 kHz	330 mV to 3.3 V	0.59 mV	
10 kHz to 20 kHz	330 mV to 3.3 V	0.73 mV	
20 kHz to 50 kHz	330 mV to 3.3 V	1.1 mV	1
50 kHz to 100 kHz	330 mV to 3.3 V	2.9 mV	1
100 kHz to 500 kHz	330 mV to 3.3 V	9.1 mV	1
Equipment to Source AC Volta At the listed frequencies ^{FO}	-		
10 Hz to 45 Hz	3.3 V to 33 V	11 mV	
45 Hz to 10 kHz	3.3 V to 33 V	5.9 mV	
10 kHz to 20 kHz	3.3 V to 33 V	9.1 mV	\mathbf{D}
20 kHz to 50 kHz	3.3 V to 33 V	13 mV	
50 kHz to 100 kHz	3.3 V to 33 V	33 mV	
Equipment to Source AC Volta At the listed frequencies ^{FO}			
45 Hz to 1 kHz	33 V to 330 V	69 mV	
1 kHz to 10 kHz	33 V to 330 V	79 mV	
10 kHz to 20 kHz	33 V to 330 V	94 mV	
20 kHz to 50 kHz	33 V to 330 V	0.12 V	
50 kHz to 100 kHz	33 V to 330 V	0.53 V	
Equipment to Source AC Volta At the listed frequencies ^{FO}			
45 Hz to 1 kHz	330 V to 1.02 kV	0.34 V	
1 kHz to 5 kHz	330 V to 1.02 kV	0.28 V	
5 kHz to 10 kHz	330 V to 1.02 kV	0.33 V	
Equipment to Source AC Curr At the Listed frequencies ^{FO}			Fluke 5522A
10 Hz to 20 Hz	29 µA to 330 µA	0.82 μΑ	
20 Hz to 45 Hz	29 µA to 330 µA	0.64 μΑ	
45 Hz to 1 kHz	29 µA to 330 µA	0.55 μΑ	



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Equipment to Source AC Current			Fluke 5522A
At the listed frequencies ^{FO}			_
1 kHz to 5 kHz	29 µA to 330 µA	1.2 μΑ	
5 kHz to 10 kHz	29 µA to 330 µA	3 μΑ	
10 kHz to 30 kHz	29 µA to 330 µA	6 μΑ	
Equipment to Source AC Curr At the listed frequencies ^{FO}	rent		
10 Hz to 20 Hz	330 µA to 3.3 mA	7.6 μΑ	
20 Hz to 45 Hz	330 µA to 3.3 mA	4.8 μΑ	_
45 Hz to 1 kHz	330 µA to 3.3 mA	3.9 µA	1
1 kHz to 5 kHz	330 µA to 3.3 mA	8 μΑ	1
5 kHz to 10 kHz	330 µA to 3.3 mA	19 µA	
10 kHz to 30 kHz	330 µA to 3.3 mA	38 µA	
Equipment to Source AC Curr At the listed frequencies ^{FO}	ent		
10 Hz to 20 Hz	3.3 mA to 33 mA	66 µA	
20 Hz to 45 Hz	3.3 mA to 33 mA	34 µA	
45 Hz to 1 kHz	3.3 mA to 33 mA	17 μA	
1 kHz to 5 kHz	3.3 mA to 33 mA	32 μA	
5 kHz to 10 kHz	3.3 mA to 33 mA	74 μΑ	
10 kHz to 30 kHz	3.3 mA to 33 mA	0.14 mA	
Equipment to Source AC Curr At the listed frequencies ^{FO}	rent		
10 Hz to 20 Hz	33 mA to 330 mA	0.65 mA	
20 Hz to 45 Hz	33 mA to 330 mA	0.34 mA	-
45 Hz to 1 kHz	33 mA to 330 mA	0.16 mA	
1 kHz to 5 kHz	33 mA to 330 mA	0.41 mA	
5 kHz to 10 kHz	33 mA to 330 mA	0.81 mA	
10 kHz to 30 kHz	33 mA to 330 mA	1.6 mA	
Equipment to Source AC Curr At the listed frequencies ^{FO}			
10 Hz to 45 Hz	330 mA to 1.1 A	2.2 mA	
45 Hz to 1 kHz	330 mA to 1.1 A	0.71 mA	
1 kHz to 5 kHz	330 mA to 1.1 A	8.1 mA	
5 kHz to 10 kHz	330 mA to 1.1 A	35 mA	1



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Equipment to Source AC Curr	rent		Fluke 5522A
At the listed frequencies ^{FO} 10 Hz to 45 Hz	1144.24	(2)	_
	1.1 A to 3 A	6.2 mA	_
45 Hz to 1 kHz	1.1 A to 3 A	2.2 mA	
1 kHz to 5 kHz	1.1 A to 3 A	21 mA	
Equipment to Source AC Curr At the listed frequencies ^{FO}			
45 Hz to 100 Hz	3 A to 11 A	10 mA	
100 Hz to 1 kHz	3 A to 11 A	15 mA	
1 kHz to 5 kHz	3 A to 11 A	0.38 A	
Equipment to Source AC Curr At the listed frequencies ^{FO}	rent		-
45 Hz to 100 Hz	11 A to 20.5 A	34 mA	
100 Hz to 1 kHz	11 A to 20.5 A	41 mA	
1 kHz to 5 kHz	11 A to 20.5 A	0.70 A	
Equipment to Measure AC Cu At the listed frequencies ^{FO}			HP 3458A Opt 002
10 Hz to 5 kHz	Up to 100 µA	0.11 μΑ	2
Equipment to Measure AC Cu At the listed frequencies ^{FO}	irrent		
10 Hz to 5 kHz	100 µA to 1 mA	0.6 μA	
Equipment to Measure AC Cu At the listed frequencies ^{FO}	irrent		-
10 Hz to 5 kHz	1 mA to 10 mA	6.1 μA	
Equipment to Measure AC Cu At the listed frequencies ^{FO}			
10 Hz to 5 kHz	10 mA to 100 mA	61 µA	
Equipment to Measure AC Cu At the listed frequencies ^{FO}]
10 Hz to 5 kHz	100 mA to 1.1 A	1.4 mA	
Equipment to Measure AC Current At the listed frequencies ^{FO}			HP 3458A Opt 002 with HP 34330A Shunt
	1.1 A to 3.3 A	13 mA	
10 Hz to 40 Hz	1.1 A to 5.5 A	15 1111	
	1.1 A to 3.3 A 1.1 A to 3.3 A	12 mA	-



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Equipment to Measure AC			HP 3458A Opt 002
At the listed frequencies FO 45 Hz to 1 kHz		42 4	with HP 34330A Shunt
45 Hz to 1 kHz	3 A to 11 A 3 A to 11 A	43 mA 43 mA	-
Equipment to Measure AC		45 IIIA	-
At the listed frequencies ^{FO}			
45 Hz to 1 kHz	11 A to 20.5 A	12 mA	
1 kHz to 5 kHz	11 A to 20.5 A	0.2 A	
Equipment to Source	100 µH to 1 mH	17 μH	GR 1491D Decade Box
Inductance FO	1 mH to 10 mH	0.14 mH	RLC GenRad 1689
	10 mH to 100 mH	0.69 mH	1
	100 mH to 1 H	6.9 mH	1
	1 H to 10 H	69 mH	1
Equipment to Measure	100 µH to 1 mH	0.24 μH	RLC GenRad 1689
Inductance FO	1 to 10 mH	2.4 μH	-
	10 mH to 100 mH	24 μH	
	100 mH to 1 H	0.24 mH	
	1 H to 10 H	2.3 mH	
Equipment to Measure	Up to 1 nF	0.64 pF	RLC GenRad 1689
Capacitance FO	1 nF to 10 nF	2.4 pF	1
	10 nF to 100 nF	26 pF	1
	100 nF to 1 µF	0.41 nF	
	1 μF to 1.111 μF 0.44 nF	0.44 nF	
Equipment to Source Capa At the listed frequencies ^{FO}	citance		1423A Decade Box
20 Hz to 1 kHz	100 pF to 1 nF	0.67 pF	1
20 Hz to 1 kHz	1 nF to 10 nF	42 pF	1
20 Hz to 1 kHz	10 nF to 100 nF	74 pF	
20 Hz to 1 kHz	100 nF to 1 µF	0.62 nF	
10 Hz to 10 kHz	220 pF to 400 pF	15 pF	Fluke 5522A
10 Hz to 10 kHz	0.4 nF to 1.1 nF	18 pF	1
10 Hz to 3 kHz	1.1 nF to 3.3 nF	23 pF	1
10 Hz to 1 kHz	3.3 nF to 11 nF	44 pF	-
10 Hz to 1 kHz	11 nF to 33 nF	0.17 nF	
10 Hz to 1 kHz	33 nF to 110 nF	0.44 nF]



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Equipment to Source Capac	citance		Fluke 5522A
At the listed frequencies FO		0.02	-
10 Hz to 1 kHz	110 nF to 330 nF	0.92 nF	-
10 Hz to 600 Hz	330 nF to 1.1 μF	4.1 nF	-
10 Hz to 300 Hz	1.1 μF to 3.3 μF	12 nF	-
10 Hz to 150 Hz	3.3μF to 11 μF	44 nF	-
10 Hz to 120 Hz	11 μF to 33 μF	0.18 μF	
10 Hz to 80 Hz	33 μF to 110 μF	0.70 μF	
0 Hz to 50 Hz	110 µF to 330 µF	2.0 µF	
Equipment to Source Capac At the listed frequencies ^{FO}			Fluke 5522A
0 Hz to 20 Hz	330 µF to 1.1 mF	12 μF	
0 Hz to 6 Hz	1.1 mF to 3.3 mF	20 μF	
0 Hz to 2 Hz	3.3 mF to 11 mF	89 µF	
0 Hz to 0.6 Hz	11 mF to 33 mF	0.31 mF	
0 Hz to 0.2 Hz	33 mF to 110 mF	1.4 mF	
Equipment to Source DC	Up to 10 Ω	1.6 mΩ	ESI RS925A Resistance
Resistance FO	10Ω to 100Ω	3.1 mΩ	Decade Box
	100 Ω to 1 k Ω	27 mΩ	
	1 kΩ to 10 kΩ	0.26 Ω	
	10 kΩ to 100 kΩ	2.6 Ω	-
	100 kΩ to 1.1 MΩ	29 Ω	-
	Up to 10 Ω	1.6 mΩ	Fluke 5522A
	1.1 MΩ to 3.3 MΩ	0.29 kΩ	
	3.3 MΩ to 11 MΩ	0.35 kΩ	-
	11 MΩ to 33 MΩ	12 kΩ	-
	33 MΩ to 110 MΩ	66 kΩ	
	110 MΩ to 330 MΩ	1.2 ΜΩ	4
	330 MΩ to 1.1 GΩ	18 MΩ	4
Equipment to Measure	Up to 10 Ω	0.31 mΩ	HP 3458A Opt 002
DC Resistance FO	10Ω to 100Ω	2.7 mΩ	
	100Ω to $1 k\Omega$	18 mΩ	4
	1 kΩ to 10 kΩ	0.18 Ω	4
	10 k Ω to 100 k Ω	1.8 Ω	4



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Equipment to Measure	100 k Ω to 1 M Ω	25 Ω	HP 3458A Opt 002
DC Resistance FO	$1 \text{ M}\Omega$ to $10 \text{ M}\Omega$	0.78 kΩ	
	10 MΩ to 100 MΩ	68 kΩ	
Oscilloscopes Amplitude -	DC FO		Fluke 5522A / SC1100
50 Ω	-6.6 V to 6.6 V	20 mV	•
1 MΩ	-130 V to 130 V	15 mV	
Amplitude - Square Wave			-
50 Ω	1 mV to 6.6 V (p-p)	13 mV	
1 MΩ	1 mV to 130 V (p-p)	18 mV	
Frequency	10 Hz to 10 kHz	29 Hz	
Time Markers into	1 ns to 20 ms	8.2 µs	
50 Ω Load	50 ms to 5 s	29 ms	
Leveled Sine Wave	50 kHz reference	0.13 V	
(5 mV to 5.5 V) p-p	50 kHz to 100 MHz	0.10 V	-
	100 MHz to 300 MHz	0.14 V	
	300 MHz to 600 MHz	0.26 V	
Leveled Sine Wave (5 mV to 3.5 V) p-p	600 MHz to 1.1 GHz	0.20 V	
Edge Characteristics into	Up to 300 ps	+0/-120 ps	
50 Ω Load Rise Time	4.5 mV to 2.75 V	63 mV	
Amplitude Frequency	1 kHz to 10 MHz	29 Hz	-
Wave Generator	1.8 mV to 55 V p-p	88 mV	
Square, Sine, Triangle	1.8 mV to 55 V p-p	2.0 V	
Amplitude Into 50 Ω Load Into 1 MΩ Load Frequency	10 Hz to 100 kHz	0.29 Hz	-
Pulse – Generate 50 Ω Load Period	22 ms to 200 ns 45.5 Hz to 5 MHz	6.1 ns	
Width	4 ns to 500 ns	1.2 ns	
Input Resistance	40Ω to 60Ω	56 mΩ	1
Measurement	500 k Ω to 1.5M Ω	2.5 kΩ	1
Oscilloscope Capacitance Measurement	5 pF to 50 pF	1.3 pF	



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Electrical Simulation of Thermocouple Indicators	600 °C to 800 °C	0.53 °C	Fluke 5522A
	800 °C to 1 000 °C	0.42 °C	
Type B ^{FO}	1 000 °C to 1 550 °C	0.37 °C	
	1 550 °C to 1 820 °C	0.40 °C	
Electrical Simulation of	0 °C to 150 °C	0.35 °C	
Thermocouple Indicators	150 °C to 650 °C	0.31 °C	
Type C ^{FO}	650 °C to 1 000 °C	0.38 °C	
	1 000 °C to 1 800 °C	0.59 °C	
	1 800 °C to 2 316 °C	0.98 °C	
Electrical Simulation of	-250 °C to -100 °C	0.58 °C	
Thermocouple Indicators	-100 °C to -25 °C	0.19 °C	
Type E ^{FO}	-25 °C to 350 °C	0.17 °C	
	350 °C to 650 °C	0.19 °C	1
	650 °C to 1 000 °C	0.25 °C	-
Electrical Simulation of	-210 °C to -100 °C	0.33 °C	
Thermocouple Indicators	-100 °C to -30 °C	0.20 °C	\supset
Type J ^{FO}	-30 °C to 150 °C	0.17 °C	
	150 °C to 760 °C	0.21 °C	
	760 °C to 1 200 °C	0.27 °C	-
Electrical Simulation of	-200 °C to -100 °C	0.39 °C	-
Thermocouple Indicators	-100 °C to -25 °C	0.22 °C	
Type K ^{FO}	-25 °C to 120 °C	0.19 °C	
	120 °C to 1 000 °C	0.31 °C	
	1 000 °C to 1 372 °C	0.48 °C	
Electrical Simulation of	-200 °C to -100 °C	0.44 °C	1
Thermocouple Indicators Type L ^{FO}	-100 °C to 800 °C	0.32 °C	1
	800 °C to 900 °C	0.22 °C	1
Electrical Simulation of	-200 °C to -100 °C	0.47 °C	1
Thermocouple Indicators	-100 °C to -25 °C	0.26 °C	1
Type N ^{FO}	-25 °C to 120 °C	0.23 °C	1
	120 °C to 410 °C	0.22 °C	1
	410 °C to 1 300 °C	0.33 °C	1



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Electrical Simulation of	0 °C to 250 °C	0.67 °C	Fluke 5522A
Thermocouple Indicators	250 °C to 400 °C	0.42 °C	
Type R ^{FO}	400 °C to 1 000 °C	0.40 °C	
	1 000 °C to 1 767 °C	0.48 °C	
Electrical Simulation of	0 °C to 250 °C	0.56 °C	
Thermocouple Indicators	250 °C to 1 000 °C	0.43 °C	
Type S ^{FO}	1 000 °C to 1 400 °C	0.44 °C	
	1 400 °C to 1 767 °C	0.54 °C	1
Electrical Simulation of	-250 °C to -150 °C	0.74 °C	1
Thermocouple Indicators Type T ^{FO}	-150 °C to 0 °C	0.30 °C	1
Type 1 10	0 °C to 120 °C	0.19 °C	
	120 °C to 400 °C	0.17 °C	
Electrical Simulation of	-200 °C to 0 °C	0.66 °C	
Thermocouple Indicators Type U ^{FO}	0 °C to 600 °C	0.33 °C	
Electrical Simulation of	-200 °C to -80 °C	0.06 °C	
RTD Indicators Pt 385, 100 Ω ^{FO}	-80 °C to 0 °C	0.06 °C	P
rt 365, 100 <u>s</u> 2	0 °C to 100 °C	0.09 °C	
	100 °C to 300 °C	0.11 °C	
	300 °C to 400 °C	0.12 °C	
	400 °C to 630 °C	0.14 °C	
	630 °C to 800 °C	0.27 °C	
Electrical Simulation of RTD Indicators Pt 385, 200 Ω ^{FO}	-200 °C to -80 °C	0.05 °C	
	-80 °C to 0 °C	0.05 °C]
	0 °C to 100 °C	0.05 °C]
	100 °C to 260 °C	0.06 °C]
	260 °C to 300 °C	0.15 °C	1
	300 °C to 400 °C	0.18 °C	1
	400 °C to 600 °C	0.18 °C	1
	600 °C to 630°C	0.19 °C	1



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Electrical Simulation of	-200 °C to -80 °C	0.05 °C	Fluke 5522A
RTD Indicators	-80 °C to 0 °C	0.06 °C	
Pt 385, 500 Ω ^{FO}	0 °C to 100 °C	0.06 °C	
	100 °C to 260 °C	0.07 °C	-
	260 °C to 300 °C	0.09 °C	-
	300 °C to 400 °C	0.09 °C	-
	400 °C to 600 °C	0.11 °C	-
	600 °C to 630 °C	0.13 °C	-
Electrical Simulation of	-200 °C to -80 °C	0.04 °C	-
RTD Indicators	-80 °C to 0 °C	0.04 °C	-
Pt 385, 1000 Ω ^{FO}	0 °C to 100 °C	0.08 °C	-
	100 °C to 260 °C	0.06 °C	-
	260 °C to 300 °C	0.00 °C	-
	300 °C to 400 °C	0.07 °C	-
	400 °C to 600 °C	0.08 °C	
	400 °C to 630 °C	0.08 C	
Phase Angle - Source (0 to 360)° ^{FO}	65 Hz to 500 Hz	0.29 °	Fluke 5522A
	Power at listed Frequencies F		
150 kHz to 1.3 GHz	-20 dBm to 30 dBm	0.21 dBm	HP 8902A / HP 11722A
1.3GHz to 18GHz	-70 dBm to 10 dBm	0.23 dBm	AGILENT E4418B /
1.50112 10 160112	10 dBm to 20 dBm	0.16 dBm	E4412A
Tuned RF Absolute	-20 dBm to 10 dBm	0.15 dBm	HP 8902A / HP 11722A
Power – Measure 2.5 MHz to 1.3 GHz ^{FO}	-40 dBm to -20 dBm	0.16 dBm	III 0902/17/III 11722/1
	-50 dBm to -40 dBm	0.11 dBm	
	-60 dBm to -50 dBm	0.07 dBm	-
	-70 dBm to -60 dBm	0.11 dBm	
	-80 dBm to -70 dBm	0.11 dBm	
	-90 dBm to -80 dBm	0.07 dBm	
	-100 dBm to -90 dBm	0.07 dBm	
	-110 dBm to -100 dBm	0.16 dBm	1
	-120 dBm to -110 dBm	0.13 dBm	
	-127 dBm to -120 dBm	0.13 dBm	1



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Electrical	0 7 7	to perjorm the jottowing e	
MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Equipment to Measure Amp			
at the listed Frequencies and		T	
Frequency: 150 kHz to 10 MHz Rate: 50 Hz to 10 kHz	5 % to 99 %	2.3 %	HP 8902A
Frequency: 150 kHz to 10 MHz Rate: 20 Hz to 10 kHz	to 99 %	3.5 %	
Frequency: 10 MHz to 1.3 GHz Rate: 50 Hz to 50 kHz	5 % to 99 %	1.2 %	
Frequency: 10 MHz to 1.3 GHz Rate: 20 Hz to 100 kHz	to 99 %	3.5 %	
Equipment to Measure Freq at the listed Frequencies and			HP 8902A
Frequency: 250 kHz to 10 MHz			
Rate: 20 Hz to 10 kHz	0 Hz to 4 kHz	0.12 kHz	
≤ 40 kHz peak	4 kHz to 40 kHz	1.1 kHz	
Frequency: 10 MHz to			
1.3 GHz	0 Hz to 4 kHz	0.18 kHz	
Rate: 50 Hz to 100 kHz	4 kHz to 40 kHz	0.64 kHz	
\leq 400 kHz peak	40 kHz to 400 kHz	4.8 kHz	
Frequency: 10 MHz to	_		
1.3 GHz	0 Hz to 4 kHz	0.3 kHz	
Rate: 20 Hz to 200 kHz	4 kHz to 40 kHz	2.5 kHz	
\leq 400 kHz peak	40 kHz to 400 kHz	24.0 kHz	
Equipment to Measure Phase at the listed Frequencies ^{FO}			
150 kHz to 10 MHz	0 to 2π rad	0.32 rad	
10 MHz to 1.3 GHz	0 to 2π rad	0.56 rad	
		•	



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Accreditation is granted to the facility to perform the following calibrations:

Thermodynamic			
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Humidity ^{FO}	Up to 10 % RH	1.4 %	Vaisala HMT 333 /
	10 % RH to 95 % RH	0.71 %	HMP75 Thunder Scientific 2500
Temperature FO	-196 °C	0.021 °C	Liquid Nitrogen
	-95 °C to -20 °C	0.021 °C	Temperature Bath Fluke 5628 PRT
	-20 °C to 150 °C	0.017 °C	HP 3458A Opt 002
	150 °C to 660 °C	0.062 °C	Ĩ

Time and Frequency

rine and riequency				
MEASURED INSTRUMENT,	RANGE OR NOMINAL	DEVICE	CALIBRATION AND	CALIBRATION
QUANTITY OR GAUGE	SIZE AS APPROPR	IATE	MEASUREMENT	EQUIPMENT
			CAPABILITY EXPRESSED	AND REFERENCE
			AS AN UNCERTAINTY (±)	STANDARDS USED
Frequency – Source ^{FO}	1 MHz to 3 GHz		29 parts in 10 ¹⁰	HP E4422B Signal
				Generator locked to
				FS725 Rubidium
				Frequency Standard
Frequency – Measure FO	0.1 GHz to 3 GHz		28 parts in 10 ¹⁰	HP 53132A

Mechanical

Wiechanical			
MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Pressure Gages & Transducers ^{FO}	-1 psig to 1 psig	0.000 24 psig	Fluke 7250LP
	1 psig to 5 psig	0.03 % of reading	Fluke PM600-A1.4M with
	5 psig to 200 psig	0.015 % of reading	Fluke 6270A Pressure Controller
	200 psig to 20 000 psig	0.012 % of reading	Fluke 93116 Deadweight Tester
Vacuum ^{FO}	Up to 15 psia	0.03 % of reading	Druck DPI 145
Mass Flow FO	0.5 sccm to 50 sccm	0.31 % of reading	Mesa Labs ML-800-3
	50 sccm to 5 000 sccm	0.16 % of reading	Mesa Labs ML-800-24
	5 slpm to 100 slpm	0.18 % of reading	Mesa Labs ML-800-75
	100 slpm to 5 000 slpm	0.28 % of reading	Fluke molbox+ mass flow terminal and Fluke 5E2-S, 2E3-S, or 1E4-S molbloc.
Liquid Flow ^{FO}	1 gpm to 60 gpm	0.45 % of reading	Cox Liquid Flow Standard



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MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Equipment to Source	2.5 in-lb to 500 in-lb	0.1 % of reading	Torque Arms,
Torque ^{FO}	41.6 ft-lb to 800 ft-lb		F Class Weights
Torque Tools ^{FO}	0.12 in-lb to 1.25 in-lb	0.6 % of reading	Mountz BMX20Z
	1.25 in-lb to 10 in-lb	0.59 % of reading	Mountz TL10i
	10 in-lb to 500 in-lb	0.30 % of reading	Norbar 50621
	42 ft-lb to 75 ft-lb	0.31 % of reading	Norbar 50593
	75 ft-lb to 750 ft-lb	0.31 % of reading	Norbar 50597

Mass, Force, and Weighing Devices

Force - Compression &	Up to 500 lbf	0.10 lbf	Class F Weights
Tension ^{FO}	500 lbf to 1 000 lbf	0.63 lbf	Load Cells
			Load Cells
	1 000 lbf to 2 500 lbf	2.1 lbf	
	2 500 lbf to 5 000 lbf	2.7 lbf	
	5 000 lbf to 7 500 lbf	5.3 lbf	
	7 500 lbf to 10 000 lbf	6.3 lbf	
	10 000 lbf to 25 000 lbf	22 lbf	
	25 000 lbf to 50 000 lbf	31 lbf	
Laboratory and Precision	Up to 20 g	14 µg	Class 1 Weights
Balances FO	(0.001mg)		
	20 to 40 g	30 µg	
	(0.01mg)		
	40 to 60 g	39 µg	
	(0.01mg)		
	60 to 80g	45 µg	
	(0.01mg)		
	80 to 100 g	71 µg	
	(0.01mg)		
	100 to 200 g	77 μg	
	(0.01mg)		
	200 to 500 g	0.89 mg	
	(0.1mg)	_	
	500 to 1 kg	2.6 mg	
	(1mg)	-	
	1 kg to 2 kg	2.8 mg	
	(1mg)	_	
	2 kg to 4 kg	4.3 mg	
	(1mg)	-	



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MEASURED INSTRUMENT, QUANTITY OR GAUGE	ighing Devices RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Laboratory and Precision	4 kg to 5 kg	14 mg	Class 1 Weights
Balances FO	Res.= (1 mg)	_	_
	5 kg to 10 kg	24 mg	
	Res.= (1 mg)		
	10 kg to 15 kg	99 mg	
	Res.= (1 mg)		
	15 kg to 20 kg	0.11g	
	Res.= (0.1 g)		
	4 kg to 5 kg	14 mg	
	Res.= (1 mg)		
Scale FO	Up to 20 lb	0.001 1 lb	Class F Weights
	Res.=(0.001 lb)		_
	20 lb to 50 lb	0.007 4 lb	
	Res.= (0.01 lb)		
	50 lb to 100 lb	0.009 6 lb	
	Res.= (0.01 lb)		_
	100 lb to 600 lb	0.077 lb	
	Res.= (0.1 lb)		-
	600 lb to 1 000 lb	0.12 lb	
	Res.= (0.11b)		
	1 000 lb to 2 000 lb	0.17 lb	
	Res.= (0.1 lb)		-
	2 000 lb to 3 000 lb	0.37 lb	
	Res.= (0.5 lb)		
	3 000 lb to 4 000 lb	0.48 lb	
EQ.	Res.= (0.5 lb)		
Pipettes ^{FO}	0.5 μL to 2 μL	0.076 μL	Micro-Balance
	2 µL to 10 µL	0.078 μL	
	10 μL to 20 μL	0.080 µL	
	20 µL to 100 µL	0.094 μL	1
	100 µL to 200 µL	0.16 μL	1
	200 µL to 500 µL	0.40 μL	1
	500 μL to 1 000 μL	0.51 μL	1
	1 000 µL to 5 100 µL	2.5 μL	1
			1

Mass, Force, and Weighing Devices



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- 1. The CMC (Calibration and Measurement Capability) stated for calibrations included on this scope of accreditation represents the smallest measurement uncertainty attainable by the laboratory when performing a more or less routine calibration of a nearly ideal device under nearly ideal conditions. It is typically expressed at a confidence level of 95 % using a coverage factor k (usually equal to 2). The actual measurement uncertainty associated with a specific calibration performed by the laboratory will typically be larger than the CMC for the same calibration since capability and performance of the device being calibrated and the conditions related to the calibration may reasonably be expected to deviate from ideal to some degree.
- 2. The laboratories range of calibration capability for all disciplines for which they are accredited is the interval from the smallest calibrated standard to the largest calibrated standard used in performing the calibration. The low end of this range must be an attainable value for which the laboratory has or has access to the standard referenced. Verification of an indicated value of zero in the absence of a standard is common practice in the procedure for many calibrations but by its definition it does not constitute calibration of zero capacity.
- 3. The presence of a superscript FO means that the laboratory performs calibration of the indicated parameter both at its fixed location and onsite at customer locations. Example: Outside Micrometer^{FO} would mean that the laboratory performs this calibration at its fixed location and onsite at customer locations.
- 4. The term L represents length in inches or millimeters as appropriate to the uncertainty statement.